OMB No. 0651-0011 Atty. Docket No.: Serial No.: **NFORMATION** 09/781,372 DISCLOSURE 56271USA5A.002 **STATEMENT** Applicant(s): Steven P. Floeder, James A. Masterman, Matthew P. Peick, Carl J. Skeps, Steven R. Wageman, Wenyuan Xu, and Xin Yu Group: Filing Date: 2623 February 12, 2001 **U.S. PATENT DOCUMENTS** Class SubCla Filing Exami **Document Number** Date Name SS Date If ner Appropr Initial iate -V15 5,440,648 08/08/1995 Roberts et al. NH 07/18/1995 Pearson et al. 5,434,629 YB 4,746,020 05/24/1988 Schenk 04/19/1994 Longest, Jr. et al. VB 5,305,392 RECEIVED 11/15/1994 Dante et al. 5,365,596 чb VB Zoller et al. 4,752,897 06/21/1988 uB Chiu et al. 6,031,931 02/29/2000 Technology Center 2600 10/04/1988 Hamada et al. v /} 4,776,023 FOREIGN PATENT DOCUMENTS Date of **Country** Class SubCla Translati **Document Number** Publication SS Ye No **PCT** WO 00/07031 02/10/2000 VB X WO 01/02840 01/11/2001 **PCT** VA 07/26/2000 Europe EP 1 022 906 V/3 WO 99/10833 03/04/1999 **PCT** VB OTHER DOCUMENTS (Including Authors, Title, Date, Pertinent Papers, letc.) "A PC-Based Real Time Defect Imaging System for High Speed Web Inspection", by J.W. Roberts, S.D. Rose, G. Jullien, L. Nichols, G. Moroscher, P.T. Jenkins, S.G. Chamberlain, 413 R. Mantha, and D.J. Litwiller, pp. 7-29 – 7-41. "Real-Time Computer Vision on PC-Cluster and Its Application to Real-Time Motion чß Capture", by Daisaku Arita, Satoshi Yonemoto, and Rin-ichiro Taniguchi, pp. 205-206. Technical Paper "The Application of a Flexible Machine Vision Architecture to the YB Inspection of Continuous Process Materials", by Brad Harkavy, from a conference attended on April 24-27, 1989. <u>v/3</u> "Flexible Circuits Roll-to-Roll A0I" by Brian Tithecott, pp. 26-32 "A New Design Environment for Defect Detection In Web Inspection Systems", by S. Hossain Hajimowlana, Roberto Musceder, Graham A. Jullien, James W. Roberts; pp. 125-136. "Parsytec HTS-2, Defect Detection and Classification Through Software vs. Dedicated Hardware", by Reinhard Rinn, Scott A. Thompson, Dr. Ralph Foehr, Friedrich Luecking, and John Torre, January 1999, pp. 110-121. **Date Considered EXAMINER** 

\*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in

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(Use as many sheets if necessary)

Page 1 of 1

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Application Number	09/781,372
Filing Date	February 2, 2001
First Named Inventor	Steven P. Floeder et al.
Art Unit	2677 2623
Examiner Name	Unknown BALI, V
Attorney Case Number	56271US002

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